## AN1431, AN1431T

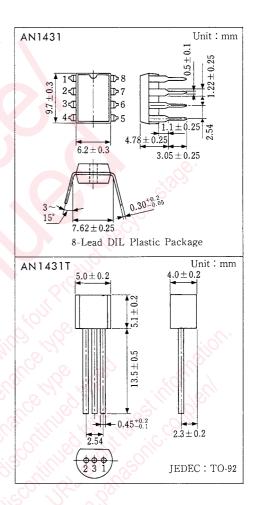
## Adjustable Precision Shunt Regulators

#### Outline

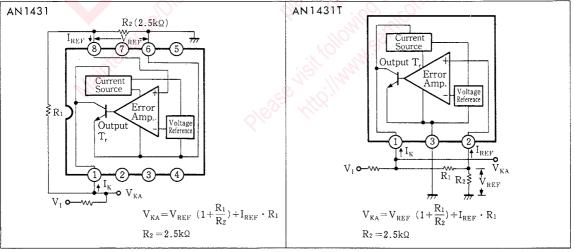
The AN1431 and the AN1431T are high precision voltage regulators which allow adjustment of output voltage between 2.5V and 36V with external resistance within the operating temperature range. Moreover, they have the fast turn-on response characteristics, allowing replacement as zener diode and application of wide range.

#### Features

- High precision output voltage: 2.5 ± 2%
- Equivalent full-range temperature: 17ppm/°C typ.
- Adjustable output voltage: 2.5~36V
- Fast turn-on response
- Low dynamic output impedance :  $0.2\Omega$  typ.
- Low output noise voltage



## ■ Block Diagrams





#### Pin

#### ● AN1431

Pin No.	Pin Name		
1	Cathode		
2	NC		
3	NC		
4	NC	· · ·	
5	NC		
6	Anode	V-4	7
7	NC		
8	Reference		

#### AN1431T

Pin No.	Pin Name
1	Cathode
2	Reference
3	Anode

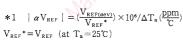
### Absolute Maximum Ratings $(T_a = 25^{\circ}C)$

	Item	Symbol	Rating	Unit
Supply Voltage		$V_{cc}$	37	V
Supply Current		$I_{cc}$	-100~+150	mA
Power Dissipation	AN1431	$P_{D}$	750	mW
	AN1431T		650	mW
Reference Input (	Current	I <sub>REF</sub>	$-0.05 \sim +10$	mA
Operating Ambient Temperature		Topr	-20~+85	$^{\circ}$
Storage Temperature		$T_{stg}$	$-55 \sim +150$	°C

## Electrical Characteristics ( $Ta = 25^{\circ}C \pm 2^{\circ}C$ )

Item	Symbol	Test Circuit	Condition	min.	typ.	max.	Unit
Reference Voltage	VREF	1	$V_{KA} = V_{REF}, I_K = 10 \text{mA}$	2.45	2.50	2.55	V
Reference Voltage Temperature Deviation	V <sub>REF(dev)</sub> *1,2	1	$V_{KA} = V_{REF}, I_{K} = 10 \text{mA}, T_{a} = 0 \sim +70 ^{\circ}\text{C}$	10	3	17	mV
Reference Voltage Fluctuation	$\Delta V_{REF}$	200	$I_{K}=10$ mA, $\Delta V_{KA}=10V\sim V_{REF}$		-1.2	-2.7	mV/V
Telefence Voltage Fractuation	$\Delta V_{KA}$	7/2	$I_{\kappa} = 10 \text{mA}, \ \Delta V_{\kappa A} = 36 \text{V} \sim 10 \text{V}$		-1	-2	mV/V
Reference Input Current	I <sub>RÉF</sub>	2	$I_{\kappa} = 10 \text{mA}, R_1 = 10 \text{k}\Omega, R_2 = \infty$	100	2	4	μΑ
Reference Input Current Temperature Deviation	I <sub>REF(dev)</sub> *2	2	$I_{K} = 10 \text{mA}, R_{1} = 10 \text{k}\Omega, R_{2} = \infty, T_{a} = 0 \sim +70 ^{\circ}\text{C}$	50-	0.4	1.2	μΑ
Minimum Cathode Current	$I_{min}$	1	$V_{KA} = V_{REF}$		0.4	1.0	mA
Off State Cathode Current	$I_{off}$	3	$V_{KA} = 36V, V_{REF} = 0V$		0.1	1.0	μΑ
Dynamic Impedance	Z <sub>KA</sub>   *3	1	$V_{KA} = V_{REF}, I_{K} = 1 \sim 100 \text{mA}, f \leq 1 \text{kHz}$		0.2	0.5	Ω

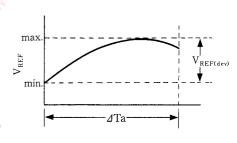
Note) The operating supply voltage range is  $V_{\text{KA}} = V_{\text{REF}}$  (2.5V~36V)



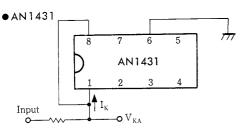
ullet Example :  $V_{\text{REF(dev)}} = 3mV$ , the temperature coefficient of  $V_{\text{REF}}$  is  $|\alpha V_{REF}| = (3mV/2500mV) \times 10^6/70^{\circ}C = 17.1(\frac{ppm}{^{\circ}C})$ 

- \*2 These values are design reference values, not guaranteed values.
- \*3 The dynamic impedance can be defined by the following expression.

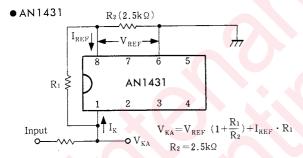
$$\mid Z_{\text{KA}}\mid = \frac{\Delta V_{\text{KA}}}{\Delta I_{\text{K}}}\left( \text{ The totall } Z_{\text{KA}} \text{ at the test circuit 2 is } \mid Z'\mid = \frac{\Delta V}{\Delta 1} \simeq \mid Z_{\text{KA}}\mid (1+\frac{R_1}{R_2}) \right)$$



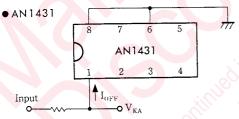
Test Circuit 1 (V<sub>REF</sub>, V<sub>REF(dev)</sub>, I<sub>min</sub>, Z<sub>KA</sub>) Note)



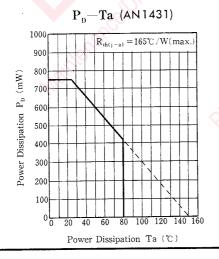
Test Circuit 2 ( $\Delta V_{REF}/\Delta V_{KA}$ ,  $I_{REF}$ ,  $I_{REF(dev)}$ ) Note)



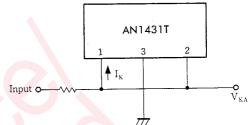
Test Circuit 3 (IOFF)



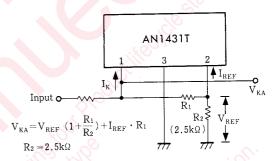
The test time should be so short that the drift in characteristic value due to the rise in chip junction temperature can be ignored.

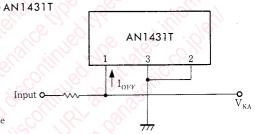


• AN 1431T

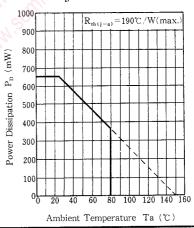


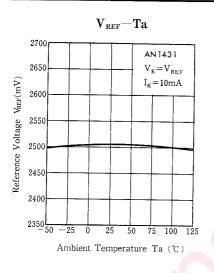
AN 1431T

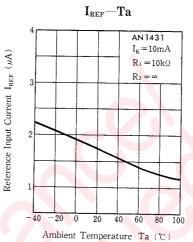




 $P_p$ -Ta (AN1431T)

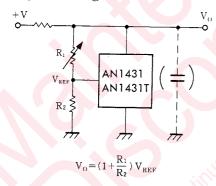




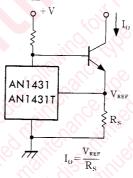


### **■** Application Circuits

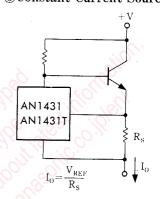
### **1**Shunt Regulator



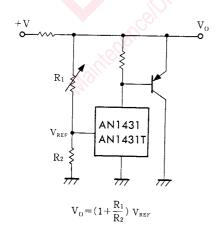




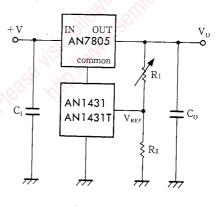
#### **3**Constant Current Source



## **High Current Shunt Regulator**



# ⑤Adjustable Output Regulator Combined with 3-Terminal Regulator



$$V_O = V_{REF} (1 + \frac{R_1}{R_2}), V_{O(min.)} = V_{REF} + 5V$$

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